FFT Spectrum Analyzers

SR760 and SR770 — 100 kHz single-channel FFT spectrum analyzers



- · DC to 100 kHz bandwidth
- · 90 dB dynamic range
- Low-distortion source (SR770)
- · Harmonic, band & sideband analysis
- 100 kHz real-time bandwidth
- Hardcopy output to printers/plotters
- · GPIB and RS-232 interfaces

SR760 & SR770 FFT Spectrum Analyzers

The SR760 and SR770 are single-channel 100 kHz FFT spectrum analyzers with a dynamic range of 90 dB and a real-time bandwidth of 100 kHz. Additionally, the SR770 includes a low-distortion source which allows you to measure the transfer functions of electronic and mechanical systems. The speed and dynamic range of these instruments, coupled with their flexibility and many analysis modes, makes them the ideal choice for a variety of applications including acoustics, vibration, noise measurement, and general electronic use.

High Dynamic Range

The SR760 and SR770 have a dynamic range of 90 dB. This means that for a full-scale input signal, the instruments have no spurious responses larger than –90 dBc (1 part in 30,000). Even signals as small as –114 dBc (1 part in 500,000) may be observed by using averaging. The low front-end noise and low harmonic distortion of the SR760 and SR770 allow you to see signals that would be buried in the noise of other analyzers.

Powerful Processing

The SR760 and SR770 use a pair of high-speed, 24-bit digital signal processors (DSPs) to filter, heterodyne and transform sampled data from its 16-bit analog-to-digital converter. This computing capability allows the analyzers to operate at a real-time bandwidth of 100 kHz. In other words, the SR760 and SR770 process the input signal with no dead time. Your measurements will be done in as little as a tenth of the time of



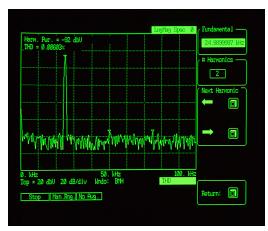
other analyzers, which typically have a real-time bandwidth of about 10 kHz.

Easy To Use

The SR760 and SR770 are easy to use. The simple, menuoriented interface logically groups related instrument functions. Context-sensitive help is available for all keys and menus, and entire instrument setups can be saved to disk and recalled with a single keystroke.

Spectrum Measurements

The spectrum, power spectral density, and input time record can be displayed in a variety of convenient linear and logarithmic units including Vp, Vrms, dBVp, dBVrms or user-defined engineering units (EUs). The magnitude, phase, and real and imaginary parts of complex signals can all be



Spectrum analysis

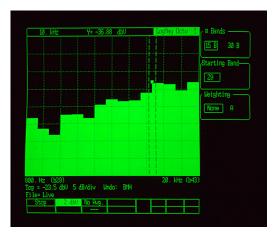
displayed. Several window functions including Hanning, Flat-Top, Uniform and Blackman-Harris can be chosen to optimize in-band amplitude accuracy or minimize out-of-band side lobes.

Triggering and Averaging

Flexible triggering and averaging modes let you see signals as low as 114 dB below full scale. RMS averaging provides an excellent estimate of the true signal and noise levels in the input signal, while vector averaging can be used with a triggered input signal to actually reduce the measured noise level. Both rms and vector averaging can be performed exponentially, where the analyzer computes a running average (weighting new data more heavily than older data), or linearly, where the analyzer computes an equally weighted average of a specified number of records. Triggering can be used to capture transient events or to preserve spectral phase information. Both internal and external triggering are available with adjustable pre-trigger and post-trigger delays.

Octave Measurements

The SR760 and SR770 also compute both the 15 and 30 band 1/3 octave spectra, commonly used in acoustics and noise measurement applications. A-weighting compensation is



Octave analysis

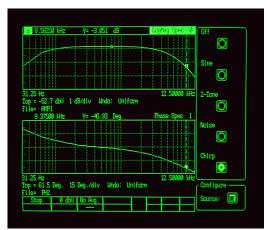
available for octave measurements. Amplitudes are computed for band –2 (630 mHz) through band 49 (80 kHz).

Synthesized Source

The SR770 includes a low-distortion (–80 dB), synthesized source which can be used to make frequency response measurements. It generates single frequency sine waves, two-tone signals for intermodulation distortion (IMD) testing, pink and white noise for audio and electronic applications, and frequency chirp for transfer function analysis. This direct digital synthesis (DDS) source provides an output level from $100~\mu V$ to 1~V, and delivers up to 50~mA of current.

Frequency Response Measurements

With its low-distortion DDS source, the SR770 is capable of performing accurate frequency response measurements. The



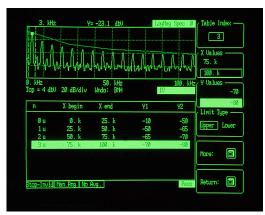
Transfer function (magnitude and phase)



source is synchronized with the instrument's input allowing transfer functions to be measured with 0.05 dB precision. The SR770 measures the magnitude and phase response of control systems, amplifiers and electro-mechanical systems, and displays the resulting Bode plot.

Limit and Data Tables

Sometimes it is important to keep track of a few key portions of a spectrum. Data tables allow up to 200 selected frequencies to be displayed in tabular format. Automated entry makes it easy to set up data tables for harmonic or sideband analysis.

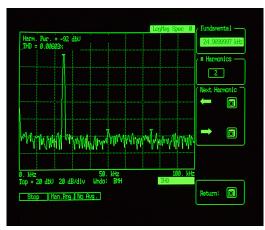


Limit and data tables

Convenient limit tables allow the entry of up to 100 separate upper or lower limit segments for pass-fail testing. On exceeding a limit, the analyzers can be configured to generate a screen message, an audio alarm, or a GPIB service request.

Analysis Modes

Three built-in analysis modes simplify common measurements. Harmonic analysis computes both harmonic power and THD (Total Harmonic Distortion) relative to a specified fundamental. Sideband analysis lets you compute power in a set of sidebands relative to the carrier power. And band



Harmonic distortion

analysis lets you easily integrate the power in a selected frequency band. All three analysis modes provide clear, on-screen markers which make it easy to pick out frequencies of special interest, such as harmonics or sidebands.

Markers

The SR760 and SR770 have a marker that is designed to be fast, responsive and flexible. The marker can be configured to read the maximum, minimum or mean of a selected width of display, or can be set to tracking mode to lock on to a moving peak. Delta-mode readouts let you easily view frequency or amplitude differences between two peaks. Automated peakfind lets you quickly move between the peaks in a spectrum. And the markers for the upper and lower displays can be linked to display similarities or differences in the two spectra.

Math Functions

Data taken with the SR760 and SR770 can be processed with the built-in trace calculator. Basic arithmetic functions such as addition, subtraction, multiplication, division, square roots and logarithms can be performed on traces. Traces can be combined with other on-screen traces, or with traces stored on disks. These calculator functions are quite useful for performing background subtraction or normalization of data.

Flexible Storage and Output

All traces, data tables and limit tables can be stored using the USB drive for SR770 and 3.5" disk drive for SR760. Data can be saved in a space-saving binary format, or an easy-to-access ASCII format for off-line analysis. A variety of hardcopy options let you easily print data from the instruments. The screen can be dumped to a dot-matrix printer or a LaserJet compatible laser printer via the standard rear-panel Centronics printer interface. Complete limit and data tables, as well as a summary of the instrument settings, can be printed. Data can be plotted to any HP-GL compatible plotter with an RS-232 or GPIB interface.

Easy to Interface

All functions of the analyzers can be queried and set via the standard RS-232 and GPIB interfaces. A comprehensive set of commands allows complete control of your analyzer from a computer. Data can be quickly transferred in binary format, or more conveniently in ASCII format. The complete command list is available as a help screen in the instruments for convenient reference while programming.



Frequency

Measurement range 476 μHz to 100 kHz Spans 191 mHz to 100 kHz in a

binary sequence

Center frequency Anywhere within the 0 to 100 kHz

measurement range

Accuracy 25 ppm from 20 °C to 40 °C

Resolution Span/400

Window functions Blackman-Harris, Hanning, Flat-Top

and Uniform

Real-time bandwidth 100 kHz

Signal Input

Number of channels 1

Input Single-ended or differential

Input impedance $1 \text{ M}\Omega$, 15 pF Coupling AC or DC

CMRR (at 1 kHz) $90 \, dB$ (input range $<-6 \, dBV$)

80 dB (input range <14 dBV)

50 dB (input range ≥14 dBV)

Noise

Typical $5 \text{ nVrms/}\sqrt{\text{Hz}}$ at 1 kHz

 $(-166 \, dBV rms / \sqrt{Hz})$

Maximum $10 \,\mathrm{nVrms}/\sqrt{\mathrm{Hz}}$

 $(-160 \, dBV rms/\sqrt{Hz})$

Amplitude

Full-scale input range -60 dBV (1.0 mVp) to

+34 dBV (50 Vp) in 2 dB steps

Dynamic range 90 dB (typ.)

Harmonic distortion No greater than -80 dB from DC to

100 kHz (input range 0 dBV)

Spurious No greater than -85 dB below full

scale (<200 Hz). No greater than -90 dB below full scale (to 100 kHz).

(-50 dBV input range) 16-bit A/D at 256 kHz

 $\begin{array}{ll} \text{Input sampling} & 16\text{-bit A/D at }256\,\text{kHz} \\ \text{Accuracy} & \pm 0.3\,\text{dB} \pm 0.02\,\% \text{ of full scale} \end{array}$

(excluding windowing effects)

Averaging RMS, Vector and Peak Hold. Linear and exponential averaging up to

and exponential averaging up to

64k scans.

Trigger Input

Modes Continuous, internal, external, TTL

Internal level Adjustable to $\pm 100\%$ of input

scale, positive or negative slope

Min. trigger amplitude 10% of input range

External level $\pm 5 \text{ V}$ in 40 mV steps, positive or

negative slope, $10 k\Omega$ impedance

Min. trigger amplitude 100 mV

External TTL Requires TTL level (low <0.7 V,

high > 2 V)

Post-trigger Measurement record is delayed by

1 to 65,000 samples (1/512 to 127 time records) after the trigger. Delay resolution is 1 sample

(1/512 of a record).

Pre-trigger Measurement record starts up to

51.953 ms prior to the trigger. Delay

resolution is 3.9062 ms.

Phase indeterminacy <2°

Display Functions

Display Real, imaginary, magnitude or phase

Measurements Spectrum, power spectral density, time record and 1/3 octave

Analysis Band, sideband, total harmonic

distortion and trace math

Graphic expand Display expand up to ×50 about

any point

Harmonic marker
Displays up to 400 harmonics
Lists Y values of up to 200 points
Limit tables
Detects data exceeding up to 100

Detects data exceeding up to 100 user-defined upper and lower limit

trace segments.

Source (SR770 only)

Amplitude range 0.1 mVp to 1.0 Vp

Amplitude resolution 1 mVp (output > 100 mVp),

 $0.1\,\mathrm{mVp}$ (output $<100\,\mathrm{mVp}$)

DC offset <10.0 mV (typ.)

Output impedance $<5 \Omega$, 50 mA peak output current

Sine Source

Frequency range DC to 100 kHz Resolution 15.26 mHz

Amplitude accuracy $\pm 1\%$ (0.09 dB) of setting

Spectral purity (Harmonics and sub-harmonics)

-80 dBc, f <10 kHz -70 dBc, f >10 kHz (Spurious)

<-100 dB full scale

Two-Tone Source

Frequency range DC to 100 kHz Resolution 15.26 mHz

Amplitude accuracy ±1% (0.09 dB) of setting Spectral purity (Harmonics and sub-harmonics)

-80 dBc (f <10 kHz)

-70 dBc (f >10 kHz)

(Spurious) <-100 dB full scale



SR760 and SR770 Specifications

White Noise Source

Frequency range DC to 100 kHz (all spans)
Flatness <1.0 dBpp (rms averaged spectra)

Pink Noise Source

Frequency range DC to 100 kHz (all spans)

Flatness <4.0 dBpp (using 1/3 oct. analysis)

Chirp Source

Output Equal amplitude sine waves at each

frequency bin of the current span

Flatness <0.05 dBpp (typ.) <0.2 dBpp (max.)

Phase AutoPhase function calibrates to

current phase spectrum.

General

Monitor Monochrome CRT, 640H by 480V

resolution, adjustable brightness

and position

Interfaces IEEE-488.2, RS-232 and Printer

interfaces standard. An XT keyboard input is provided for

additional flexibility.

Hardcopy Screen dumps and table and setting

listings to dot matrix and LaserJet compatible printers. Data plots to HP-GL compatible plotters (RS-232

or IEEE-488.2).

Data storage USB drive for SR770

Disk drive for SR760

Power 60 W, 100/120/220/240 VAC,

50/60 Hz

Dimensions $17" \times 6.25" \times 18.5"$ (WHD)

Weight 36 lbs.

Warranty One year parts and labor on defects

in materials and workmanship

Ordering Information

SR760 FFT spectrum analyzer

SR770 FFT spectrum analyzer w/source

O760H Carrying handle O760RM Rack mount kit



SR760 and SR770 rear panel

